

<b>Notice of References Cited</b>	Application/Control No. 10/775,078	Applicant(s)/Patent Under Reexamination OGAWA ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-3,741,643	06-1973	Smith et al.	399/249
	B	US-5,661,872	09-1997	Meyer et al.	15/309.2
	C	US-5,418,349	05-1995	Swain et al.	219/121.84
	D	US-5,362,588	11-1994	Yoshihara et al.	430/69
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
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	Q					
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	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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